SN54AHCT157, SN74AHCT157 QUADRUPLE 2-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS

SCLS347D - MAY 1996 - REVISED MAY 1997

- Inputs Are TTL-Voltage Compatible
- EPIC[™] (Enhanced-Performance Implanted CMOS) Process
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

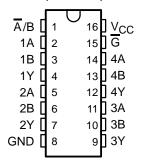
description

These quadruple 2-line to 1-line data selectors/multiplexers are designed for 4.5-V to $5.5\text{-V}\ \text{V}_{CC}$ operation.

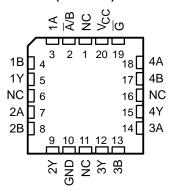
The 'AHCT157 feature a common strobe $\overline{(G)}$ input. When the strobe is high, all outputs are low. When the strobe is low, a 4-bit word is selected from one of two sources and is routed to the four outputs. The devices provide true data.

The SN54AHCT157 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74AHCT157 is characterized for operation from -40°C to 85°C.

SN54AHCT157 . . . J OR W PACKAGE SN74AHCT157 . . . D, DB, N, OR PW PACKAGE (TOP VIEW)



SN54AHCT157...FK PACKAGE (TOP VIEW)



NC - No internal connection

FUNCTION TABLE

	INPU	OUTPUT		
G	Ā/B	Α	В	Y
Н	Х	Χ	Χ	L
L	L	L	Χ	L
L	L	Н	Χ	Н
L	Н	Χ	L	L
L	Н	Χ	Н	Н

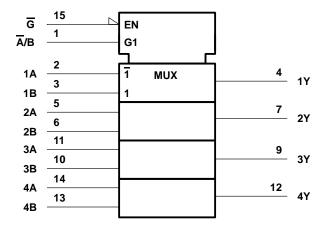


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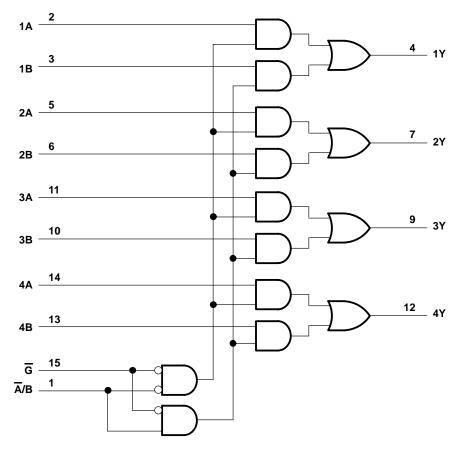


logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, J, N, PW, and W packages.

logic diagram (positive logic)



Pin numbers shown are for the D, DB, J, N, PW, and W packages.



SN54AHCT157, SN74AHCT157 QUADRUPLE 2-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}		–0.5 V to 7 V
Input voltage range, V _I (see Note 1)		0.5 V to 7 V
Output voltage range, VO (see Note 1)		V to V_{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$)		
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CO}$	g)	±20 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	·····	±25 mA
Continuous current through V _{CC} or GND		
Package thermal impedance, θ_{JA} (see Note 2):	: D package	113°C/W
, 3 ,1,1	DB package	131°C/W
	N package	78°C/W
	PW package	149°C/W
Storage temperature range, T _{stg}		_65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions (see Note 3)

		SN54AH	SN54AHCT157		SN74AHCT157		
		MIN	MAX	MIN	MAX	UNIT	
Vcс	Supply voltage	4.5	5.5	4.5	5.5	V	
٧ _{IH}	High-level input voltage	2		2		V	
V _{IL}	Low-level input voltage		0.8		0.8	V	
VI	Input voltage	0	5.5	0	5.5	V	
۷o	Output voltage	0	VCC	0	VCC	V	
ІОН	High-level output current		-8		-8	mA	
loL	Low-level output current		8		8	mA	
Δt/Δν	Input transition rise or fall time		20		20	ns/V	
TA	Operating free-air temperature	-55	125	-40	85	°C	

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	vcc	T _A = 25°C			SN54AHCT157		SN74AHCT157		UNIT
PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
.,	I _{OH} = -50 μA	451/	4.4	4.5		4.4		4.4		V
Voн	I _{OH} = -8 mA	4.5 V	3.94			3.8		3.8		
.,	I _{OL} = 50 μA	4.5 V			0.1		0.1		0.1	V
VOL	I _{OL} = 8 mA				0.36		0.44		0.44	ı v
lį	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1		±1	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			2		20		20	μΑ
∆lCC [‡]	One input at 3.4 V, Other inputs at V _{CC} or GND	5.5 V			1.35		1.5		1.5	mA
Ci	V _I = V _{CC} or GND	5 V		4.5						pF

[‡]This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.



^{2.} The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

PRODUCT PREVIEW

switching characteristics over recommended operating free-air temperature range, $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ (unless otherwise noted) (see Figure 1)

				SN					
PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°	C	MIN	MAX	UNIT	
	(1141 01)	(0011 01)		MIN TYP	MAX	IVIIIV	WAX		
^t PLH*	A or B	Y	C _L = 15 pF	4.1	6.4	1	7.5	ns	
^t PHL*		ī	OL = 15 pr	4.1	6.4	1	7.5	115	
^t PLH*		Y	C _L = 15 pF	5.3	8.1	1	9.5	20	
tPHL*	A/B	1	т С[= 15 рг	CL = 15 pr	5.3	8.1	1	9.5	ns
^t PLH*	G	Y	C _I = 15 pF	5.6	8.6	1	10	ns	
^t PHL*	G	'	OL = 13 pr	5.6	8.6	1	10	115	
^t PLH	A or B	Y C _I = 50 pF	C: 50 pF	5.6	8.4	1	9.5	20	
^t PHL	AUID	Ť	C _L = 50 pF	5.6	8.4	1	9.5	ns	
^t PLH		Y	C _I = 50 pF	6.8	10.1	1	11.5	20	
^t PLH	A/B	r	OL = 50 pr	6.8	10.1	1	11.5	ns	
^t PLH	G	Y	C: - 50 pE	7.1	10.6	1	12	ns	
^t PHL	G	ī	C _L = 50 pF	7.1	10.6	1	12	115	

^{*} On products compliant to MIL-PRF-38535, this parameter is ensured but not production tested.

switching characteristics over recommended operating free-air temperature range, $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ (unless otherwise noted) (see Figure 1)

	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE																		
PARAMETER				T _A = 25°C			MIN	MAX	UNIT												
	(01)	(0011 01)	OAI AOITAIVOE	MIN	TYP	MAX	IVIIIV	WAX													
^t PLH	A or B	Y	C _I = 15 pF		4.1	6.4	1	7.5	ns												
^t PHL		•	OL = 13 pi		4.1	6.4	1	7.5	115												
t _{PLH}	Ā/B	Y	C _L = 15 pF		5.3	8.1	1	9.5	ns												
^t PHL	A/B	•	OL = 13 pr		5.3	8.1	1	9.5	110												
^t PLH	IG	Y	C _L = 15 pF		5.6	8.6	1	10	ns												
^t PHL	G		T			'	ı	OL = 13 pi		5.6	8.6	1	10	115							
t _{PLH}	A or B	Y C _L = 50 pF		5.6	8.4	1	9.5														
^t PHL	AUIB		Ť	C[= 50 pr		5.6	8.4	1	9.5	ns											
^t PLH	_ A/B	Y	C _I = 50 pF		6.8	10.1	1	11.5													
^t PLH	A/B	Y	f	Ť	1	r	r	l T	l T	Y	f	Ť	Ť	Ť	1 CL = 50 pr		6.8	10.1	1	11.5	ns
t _{PLH}	G	Y	C _I = 50 pF		7.1	10.6	1	12	ns												
^t PHL	9	ſ	OL = 50 pr		7.1	10.6	1	12	115												

noise characteristics V_{CC} = 5 V, C_L = 50 pF, T_A = 25°C (see Note 4)

	PARAMETER		SN74AHCT157		
			MAX	UNIT	
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.8	V	
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}		-0.8	V	
VOH(V)	Quiet output, minimum dynamic VOH			V	
VIH(D)	High-level dynamic input voltage	2		V	
V _{IL(D)}	Low-level dynamic input voltage		0.8	V	

NOTE 4: Characteristics are determined during product characterization and ensured by design for surface-mount packages only.

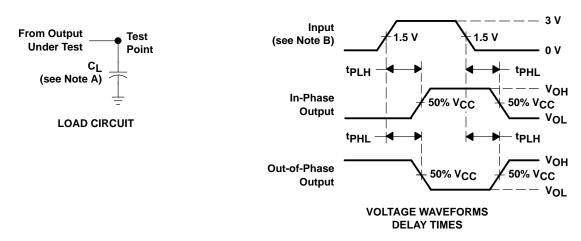


PRODUCT PREVIEW

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER		ONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	26	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f = 3 ns, t_f = 3 ns.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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